

Search Notes

Application/Control No.

10/671,025

Examiner

Chuck Huynh

Applicant(s)/Patent under
Reexamination

KIM ET AL.

Art Unit

2683

SEARCHED

Class	Subclass	Date	Examiner
455	90.3	7/20/2005	CH
455	11.1	7/20/2005	CH
455	90.1	7/20/2005	CH
455	572	7/20/2005	CH
455	550.1	7/20/2005	CH
379	433.08	7/20/2005	CH
320	Full	7/20/2005	CH
455	572	7/20/2005	CH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Class and Subclass	7/20/2005	CH
Text Search Combined with class and subclass	7/20/2005	CH